

● General Description

The AGM60P20D combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$

This device is ideal for load switch and battery protection applications.

● Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

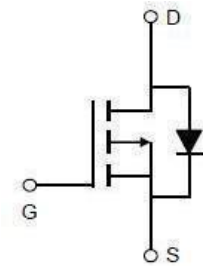
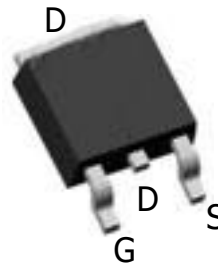
● Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Product Summary

BVDSS	RDS(ON)	ID
-60V	57mΩ	-18A

TO-252 Pin Configuration



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM60P20D	AGM60P20D	TO-252	330mm	16mm	2500

Table 1. Absolute Maximum Ratings (Tc=25°C)

Symbol	Parameter	Value	Unit
VDS	Drain-Source Voltage (VGS=0V)	-60	V
VGS	Gate-Source Voltage (VDS=0V)	±20	V
ID	Drain Current-Continuous(Tc=25°C) (Note 1)	-18	A
	Drain Current-Continuous(Tc=100°C)	-11	A
IDM (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 2)	-72	A
PD	Maximum Power Dissipation(Tc=25°C)	32	w
	Maximum Power Dissipation(Tc=100°C)	12.8	w
EAS	Avalanche energy (Note 3)	60	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Typ	Max	Unit
RθJA	Thermal Resistance Junction-ambient (Steady State) ¹	---	50	°C/W
RθJC	Thermal Resistance Junction-Case ¹	---	3.9	°C/W

Table 3. Electrical Characteristics (Tc=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
On/Off States						
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=-250μA	-60	--	--	V
IDSS	Zero Gate Voltage Drain Current	VDS=-60V,VGS=0V	--	--	-1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V	--	--	±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=-250μA	-1.3	-1.8	-2.1	V
gFS	Forward Transconductance	VDS=5V,ID=-5A	--	7.0	--	S
RDS(on)	Drain-Source On-State Resistance	VGS=-10V, ID=-10A	--	57	80	mΩ
		VGS=-4.5V, ID=-5A	--	65	95	mΩ
Dynamic Characteristics						
Ciss	Input Capacitance	VDS=-25V,VGS=0V, F=1MHZ	--	525	--	pF
Coss	Output Capacitance		--	80	--	pF
Crss	Reverse Transfer Capacitance		--	3.9	--	pF
Rg	Gate resistance	f=1.0MHz	--	3.5	--	Ω
Switching Times						
td(on)	Turn-on Delay Time	VGS=-10V,VDS=-30V, ID=-5A,RGEN=3Ω	--	10	--	nS
tr	Turn-on Rise Time		--	6.0	--	nS
td(off)	Turn-Off Delay Time		--	40	--	nS
tf	Turn-Off Fall Time		--	13	--	nS
Qg	Total Gate Charge	VGS=-10V, VDS=-30V, ID=-5A	--	8.5	--	nC
Qgs	Gate-Source Charge		--	1.8	--	nC
Qgd	Gate-Drain Charge		--	1.5	--	nC
Source-Drain Diode Characteristics						
ISD	Source-Drain Current(Body Diode)		--	--	-18	A
VSD	Forward on Voltage	VGS=0V,IS=-10A	--	--	-1.2	V
trr	Reverse Recovery Time	Isd=-10A , di/dt=100A/μs , TJ=25°C	--	50	--	ns
Qrr	Reverse Recovery Charge		--	105	--	nc

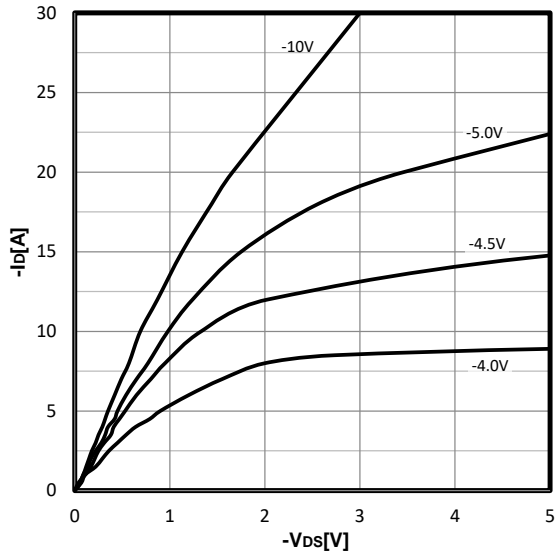
Notes 1.The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

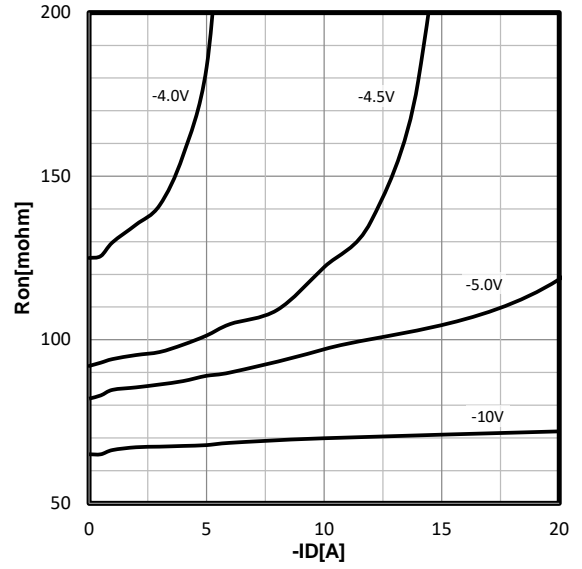
Notes 3.EAS condition: TJ=25°C

Typ. output characteristics

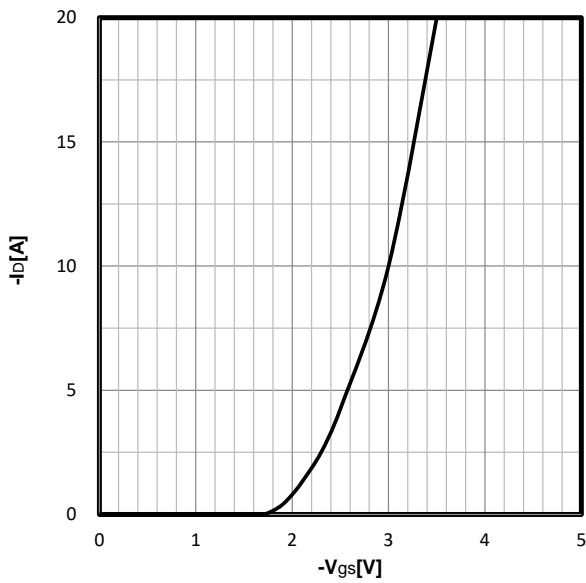
$$-I_D = f(-V_{DS})$$


Typ. drain-source on resistance

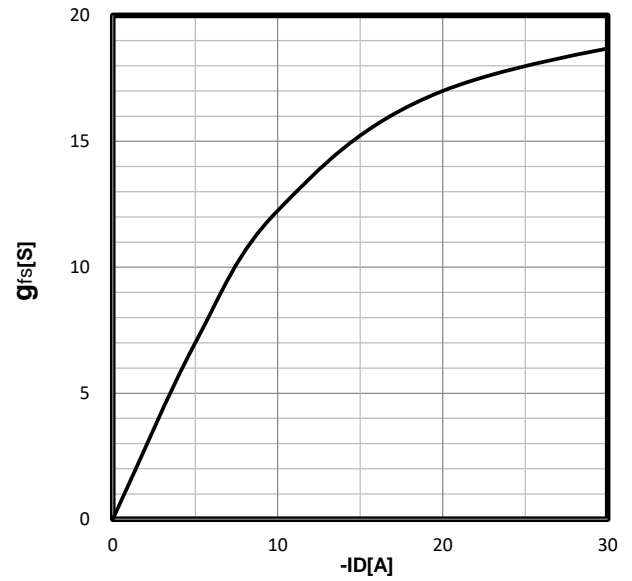
$$R_{DS(on)} = f(-I_D)$$


Typ. transfer characteristics

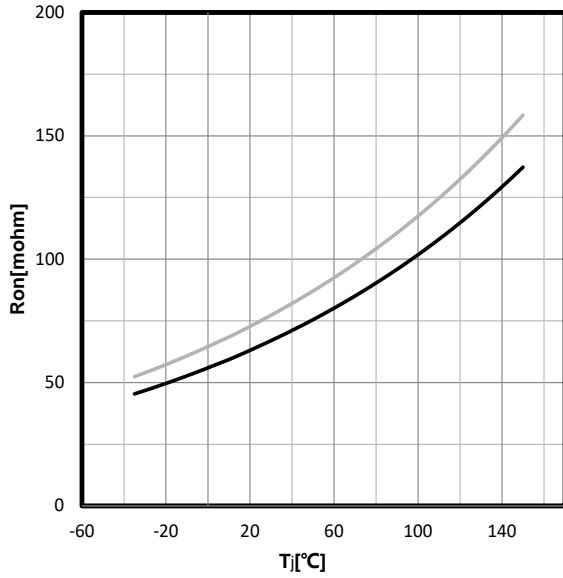
$$-I_D = f(-V_{GS})$$


Typ. forward transconductance

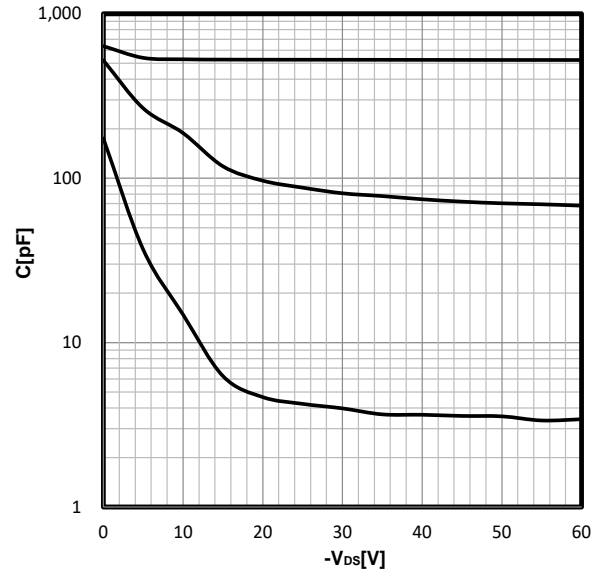
$$g_{fs} = f(-I_D)$$



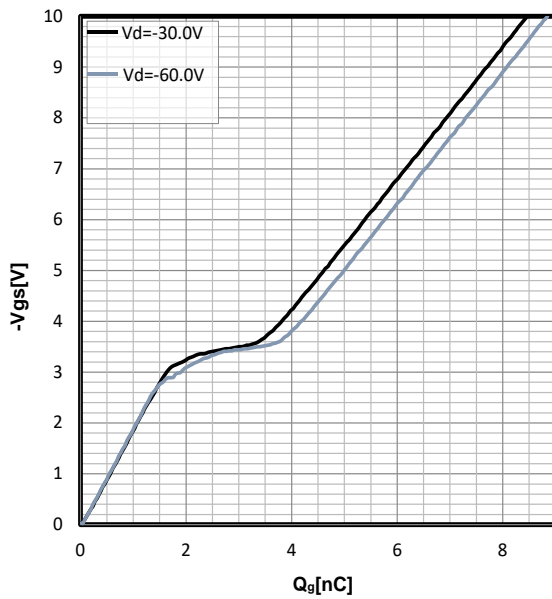
Drain-source on-state resistance
 $R_{DS(on)}=f(T_j)$; $I_D=-5.0A$; $V_{GS}=-10V$



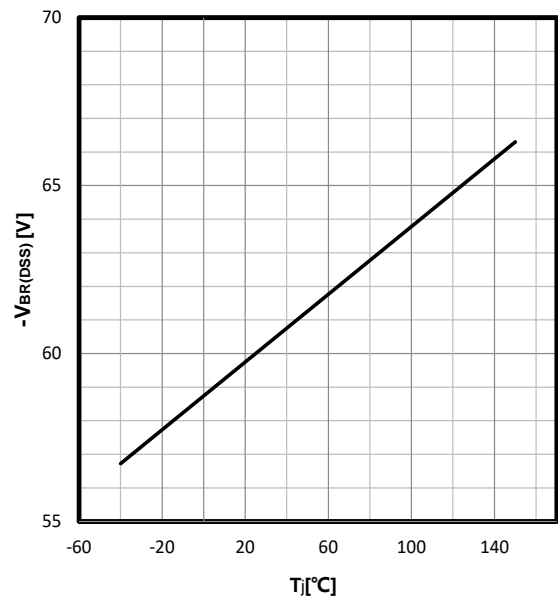
Typ. capacitances
 $C=f(-V_{DS})$; $V_{GS}=0V$; $f=1MHz$



Typ. gate charge
 $-V_{GS}=f(Q_{gate})$; $I_D=-5A$

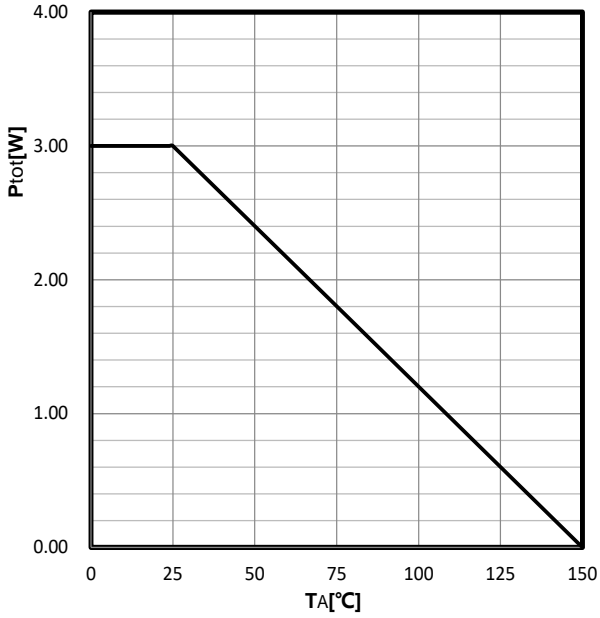


Drain-source breakdown voltage
 $-V_{BR(DSS)}=f(T_j)$; $I_D=-250uA$



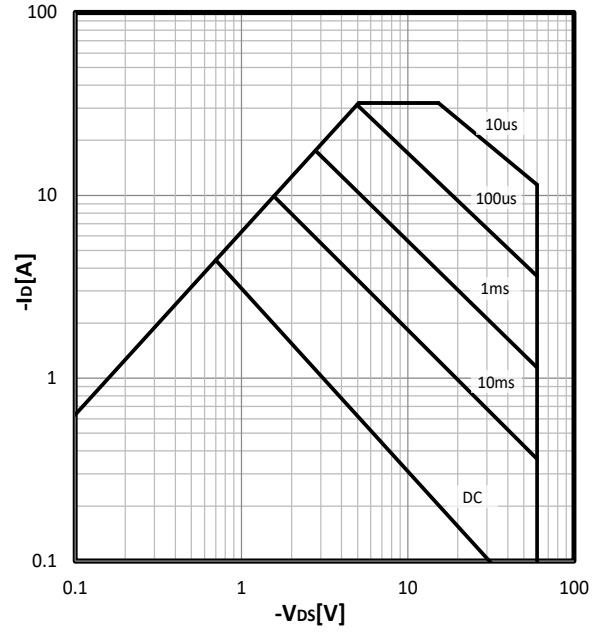
Power Dissipation

$P_{tot}=f(T_A)$



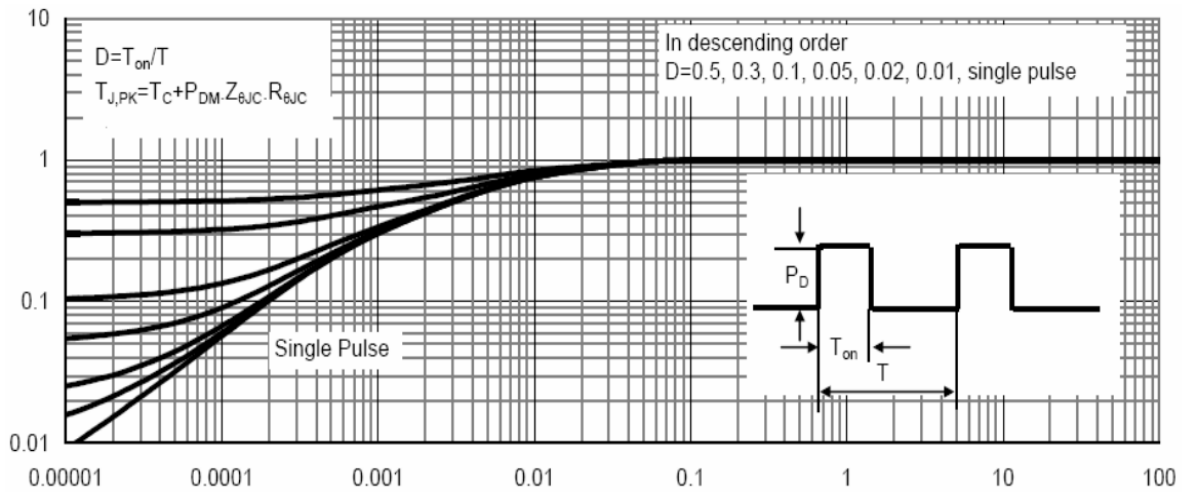
Safe operating area

$-I_D=f(-V_{DS})$

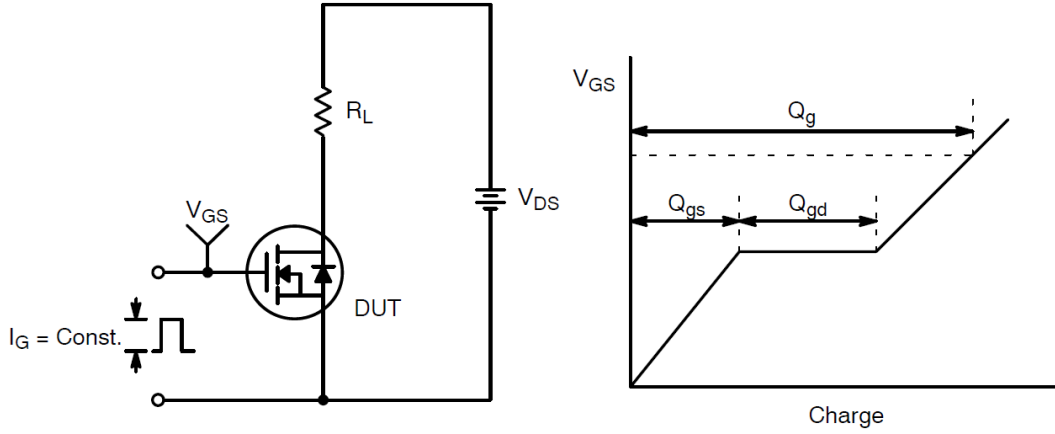


Max. transient thermal impedance

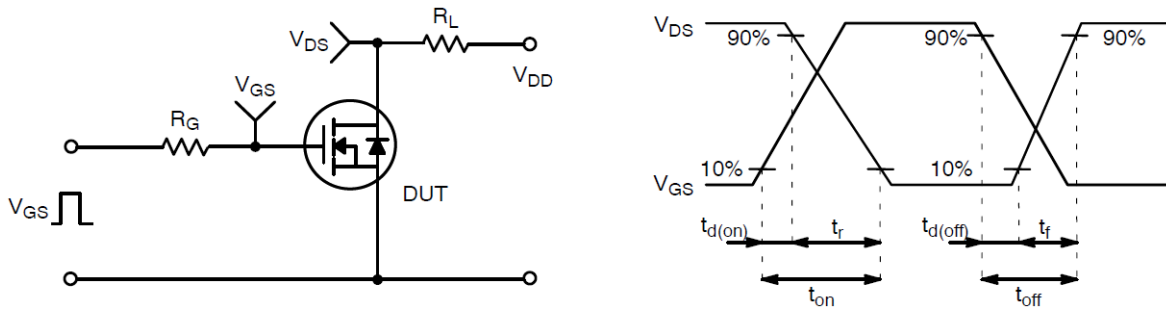
$Z_{thJC}=f(t_p)$



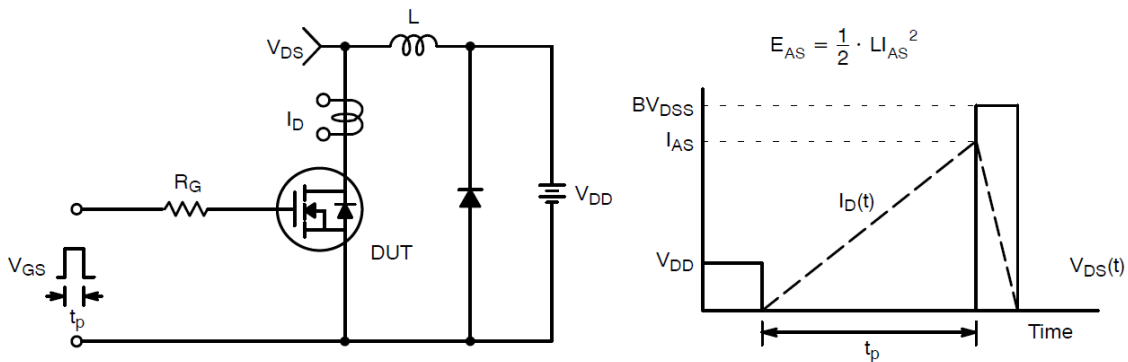
Test Circuit and Waveform:



Gate Charge Test Circuit & Waveform

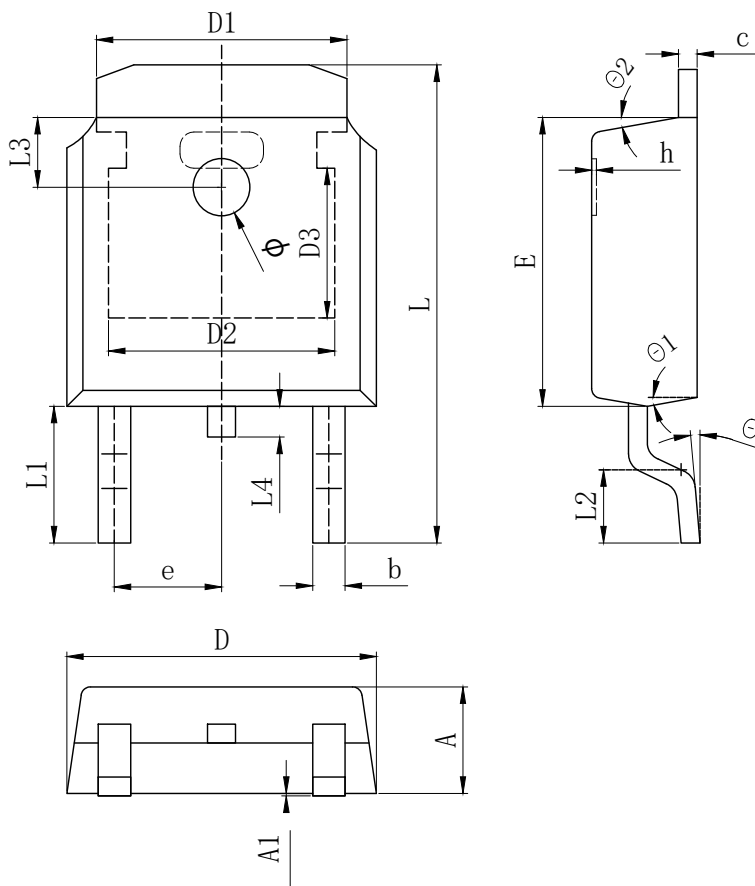


Resistive Switching Test Circuit & Waveforms

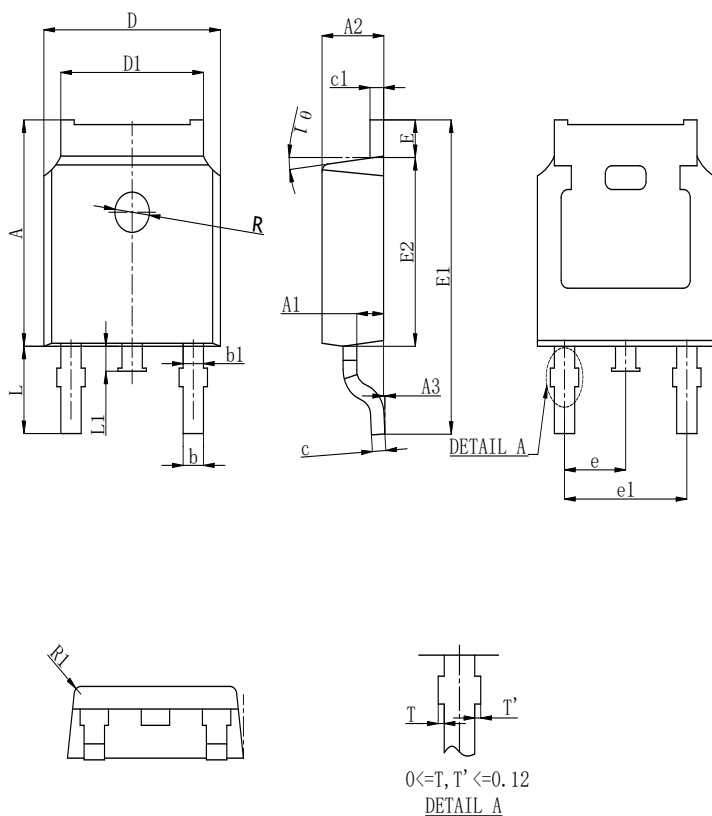


Unclamped Inductive Switching Test Circuit & Waveforms

TO-252 Package Outline Data



SYMBOL	MILLIMETER		
	MIN	Typ.	MAX
A	2.200	2.300	2.400
A1	0.000		0.127
b	0.640	0.690	0.740
c (电镀后)	0.460	0.520	0.580
D	6.500	6.600	6.700
D1	5.334 REF		
D2	4.826 REF		
D3	3.166 REF		
E	6.000	6.100	6.200
e	2.286 TYP		
h	0.000	0.100	0.200
L	9.900	10.100	10.300
L1	2.888 REF		
L2	1.400	1.550	1.700
L3	1.600 REF		
L4	0.600	0.800	1.000
phi	1.100	1.200	1.300
theta	0°		8°
theta 1	9° TYP		
theta 2	9° TYP		



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	7.050	7.100	7.150
A1	0.960	1.010	1.060
A2	2.250	2.300	2.350
A3	0.000	0.050	0.100
b	0.760REF.		
b1	1.000REF.		
c	0.508REF.		
c1	0.508REF.		
D	6.550	6.600	6.650
D1	5.220	5.320	5.420
E	0.950	1.000	1.050
E1	9.700	9.900	10.100
E2	6.050	6.100	6.150
e	2.286BSC		
e1	4.572REF.		
L	2.650	2.800	2.950
L1	0.700	0.800	0.900
theta 1	7° REF.		
R	1.300REF.		
R1	0.250REF.		


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